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Faulk, Devona E (Assistant Examiner)	07/16/2007 (Date)	WIVIAN CHIN SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2300	Total Claims Allowed: 1	
Legal Instruments Examiner	01/05/07 (Date)	(Primary Examiner) (Date)	O.G. Print Claim(s) 10	O.G. Print Figure 2